

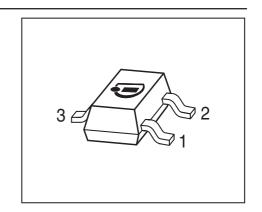
SMBT2222A/MMBT2222A

NPN Silicon Switching Transistor

- Low collector-emitter saturation voltage
- Complementary type:
 SMBT2907A / MMBT2907A (PNP)
- Pb-free (RoHS compliant) package
- Qualified according AEC Q101







Туре	Marking	Pin Configuration			Package
SMBT2222A/MMBT2222A	s1P	1 = B	2 = E	3 = C	SOT23

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CEO}	40	V
Collector-base voltage	V_{CBO}	75	
Emitter-base voltage	V_{EBO}	6	
Collector current	I _C	600	mA
Total power dissipation-	P _{tot}	330	mW
<i>T</i> _S ≤ 77 °C			
Junction temperature	T _i	150	°C
Storage temperature	T _{stg}	-65 150	

Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R _{thJS}	≤ 220	K/W

 $^{^{1}}$ For calculation of R_{thJA} please refer to Application Note AN077 (Thermal Resistance Calculation)



SMBT2222A/MMBT2222A

Electrical Characteristics at $T_A = 25^{\circ}$ C, unless otherwise specified

Parameter Parameter $I_A = 25 \text{ C}$	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics			1	1	
Collector-emitter breakdown voltage	V _{(BR)CEO}	40	-	-	V
$I_{\rm C}$ = 10 mA, $I_{\rm B}$ = 0					
Collector-base breakdown voltage	$V_{(BR)CBO}$	75	-	-	
$I_{\rm C} = 10 \ \mu {\rm A}, \ I_{\rm E} = 0$					
Emitter-base breakdown voltage	$V_{(BR)EBO}$	6	-	-	
$I_{\rm E}$ = 10 μ A, $I_{\rm C}$ = 0					
Collector-base cutoff current	I _{CBO}				μA
$V_{\rm CB} = 60 \text{ V}, I_{\rm E} = 0$		-	-	0.01	
V_{CB} = 60 V, I_{E} = 0 , T_{A} = 150 °C		-	-	10	
Emitter-base cutoff current	I _{EBO}	-	-	10	nA
$V_{\rm EB} = 3 \text{ V}, I_{\rm C} = 0$					
DC current gain ¹⁾	h _{FE}				-
$I_{\rm C}$ = 100 μ A, $V_{\rm CE}$ = 10 V		35	-	_	
$I_{\rm C}$ = 1 mA, $V_{\rm CE}$ = 10 V		50	-	-	
$I_{\rm C}$ = 10 mA, $V_{\rm CE}$ = 10 V		75	-	-	
$I_{\rm C}$ = 150 mA, $V_{\rm CE}$ = 1 V		50	-	-	
$I_{\rm C}$ = 150 mA, $V_{\rm CE}$ = 10 V		100	-	300	
$I_{\rm C}$ = 500 mA, $V_{\rm CE}$ = 10 V		40	-	-	
Collector-emitter saturation voltage ¹⁾	V _{CEsat}				V
$I_{\rm C}$ = 150 mA, $I_{\rm B}$ = 15 mA		-	_	0.3	
$I_{\rm C}$ = 500 mA, $I_{\rm B}$ = 50 mA		-	_	1	
Base emitter saturation voltage ¹⁾	V _{BEsat}				
$I_{\rm C}$ = 150 mA, $I_{\rm B}$ = 15 mA		0.6	_	1.2	
$I_{\rm C}$ = 500 mA, $I_{\rm B}$ = 50 mA		-	_	2	

¹Pulse test: t < 300μs; D < 2%



SMBT2222A/MMBT2222A

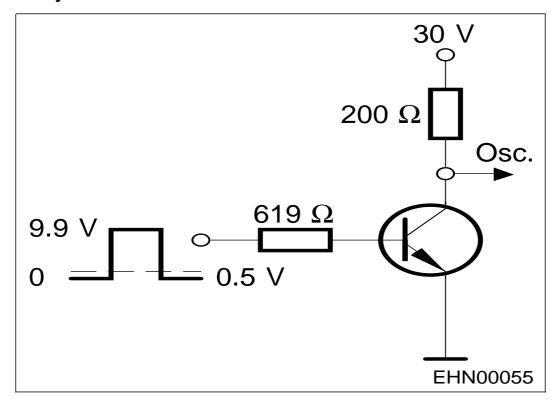
Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol		Values		Unit
		min.	typ.	max.	
AC Characteristics	·	,	,	•	·
Transition frequency	f_{T}	300	-	-	MHz
$I_{\rm C}$ = 20 mA, $V_{\rm CE}$ = 20 V, f = 100 MHz					
Collector-base capacitance	C _{cb}	-	2.5	5	pF
$V_{\text{CB}} = 10 \text{ V}, f = 1 \text{ MHz}$					
Emitter-base capacitance	C _{eb}	-	-	35	
$V_{\text{EB}} = 0.5 \text{ V}, f = 1 \text{ MHz}$					
Short-circuit input impedance	h _{11e}				kΩ
$I_{\rm C}$ = 1 mA, $V_{\rm CE}$ = 10 V, f = 1 kHz		2	-	8	
$I_{\rm C}$ = 10 mA, $V_{\rm CE}$ = 10 V, f = 1 kHz		0.25	_	1.25	
Open-circuit reverse voltage transf. ratio	h _{12e}				10-4
$I_{\rm C}$ = 1 mA, $V_{\rm CE}$ = 10 V, f = 1 kHz			-	8	
$I_{\rm C}$ = 10 mA, $V_{\rm CE}$ = 10 V, f = 1 kHz		-	-	4	
Short-circuit forward current transf. ratio	h _{21e}				-
$I_{\rm C}$ = 1 mA, $V_{\rm CE}$ = 10 V, f = 1 kHz		50	-	300	
$I_{\rm C}$ = 10 mA, $V_{\rm CE}$ = 10 V, f = 1 kHz		75	-	375	
Open-circuit output admittance	h _{22e}				μS
$I_{\rm C}$ = 1 mA, $V_{\rm CE}$ = 10 V, f = 1 kHz		5	-	35	
$I_{\rm C}$ = 10 mA, $V_{\rm CE}$ = 10 V, f = 1 kHz		25	-	200	
Delay time	<i>t</i> _d	-	-	10	ns
$V_{\rm CC}$ = 30 V, $I_{\rm C}$ = 150 mA, $I_{\rm B1}$ = 15 mA,					
$V_{BE(off)} = 0.5 V$					
Rise time	t _r	-	-	25	
$V_{\rm CC}$ = 30 V, $I_{\rm C}$ = 150 mA, $I_{\rm B1}$ = 15 mA,					
$V_{\text{BE(off)}} = 0.5 \text{ V}$					
Storage time	t _{stg}	-	_	225	
$V_{\rm CC}$ = 30 V, $I_{\rm C}$ = 150 mA, $I_{\rm B1}$ = $I_{\rm B2}$ = 15mA					
Fall time	t _f	_	_	60	
$V_{\rm CC}$ = 30 V, $I_{\rm C}$ = 150 mA, $I_{\rm B1}$ = $I_{\rm B2}$ = 15mA					
Noise figure	F	_	-	4	dB
$I_{\rm C}$ = 100 μ A, $V_{\rm CE}$ = 10 V, f = 1 kHz,					
Δf = 200 Hz, R_S = 1 k Ω					

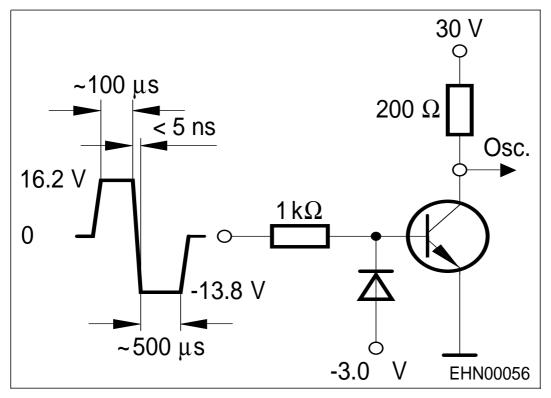


Test circuit

Delay and rise time



Storage and fall time



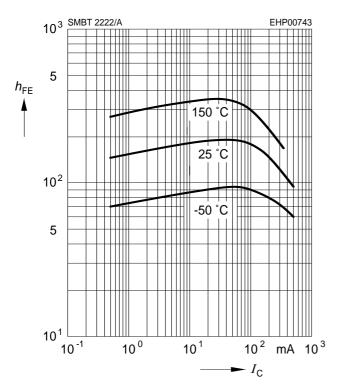
Oscillograph: $R > 100\Omega$, C < 12pF, $t_{\Gamma} < 5ns$





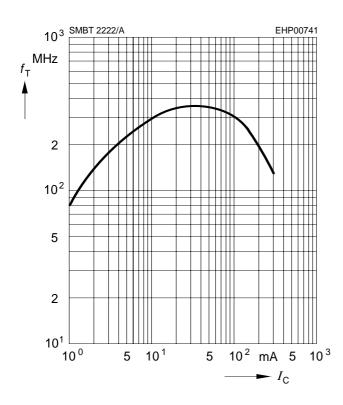
DC current gain $h_{FE} = f(I_C)$

$$V_{CE}$$
 = 10 V

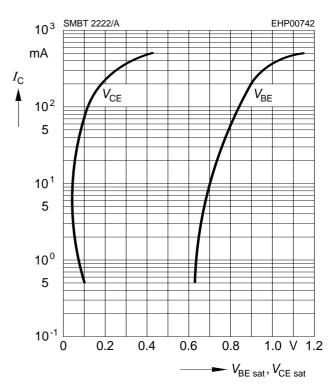


Transition frequency $f_T = f(I_C)$

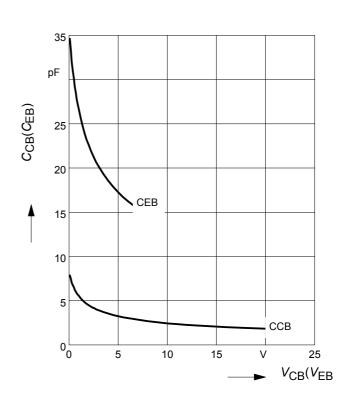
$$V_{CE}$$
 = 20 V



Saturation voltage $I_C = f(V_{BEsat}; V_{CEsat})$ $h_{FE} = 10$

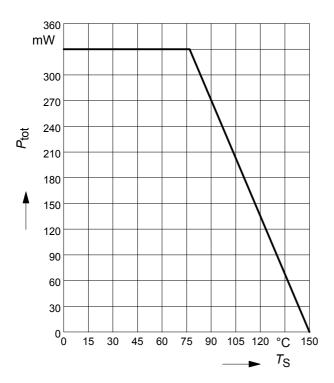


Collector-base capacitance $C_{cb} = f(V_{CB})$ Emitter-base capacitance $C_{eb} = f(V_{EB})$

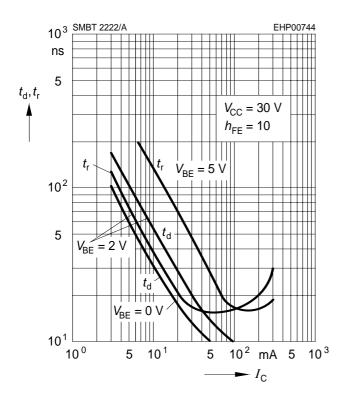




Total power dissipation $P_{\text{tot}} = f(T_{\text{S}})$

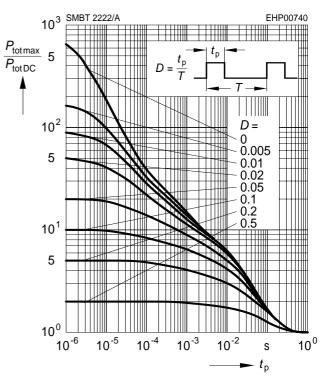


Delay time $t_d = f(I_C)$ Rise time $t_f = f(I_C)$

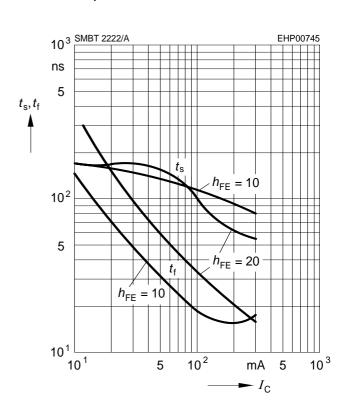


Permissible Pulse Load

 $P_{\text{totmax}}/P_{\text{totDC}} = f(t_{p})$

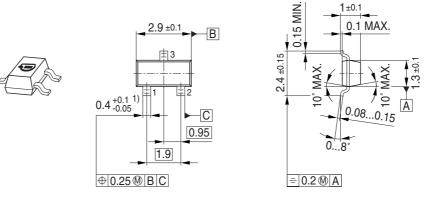


Storage time $t_{stg} = f(I_C)$ Fall time $t_f = f(I_C)$



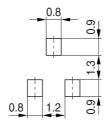


Package Outline

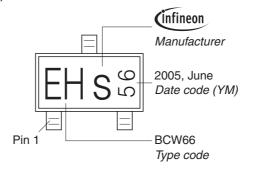


1) Lead width can be 0.6 max. in dambar area

Foot Print

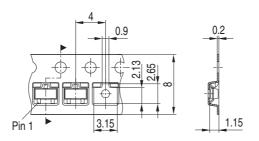


Marking Layout (Example)



Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel





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